

UNISONIC TECHNOLOGIES CO., LTD

1NM70-V **Preliminary Power MOSFET**

1.0A, 700V N-CHANNEL SUPER-JUNCTION MOSFET

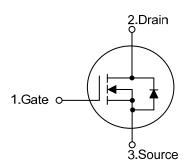
DESCRIPTION

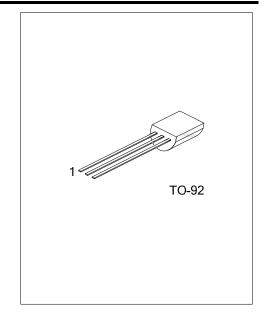
The UTC 1NM70-V is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at AC-DC converters for power applications.

FEATURES

- * $R_{DS(on)} \le 3.5 \ \Omega$ @ V_{GS} =10V, I_D =0.5A
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

SYMBOL

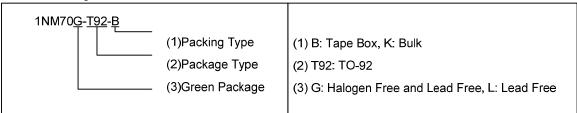




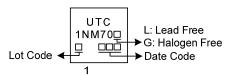
ORDERING INFORMATION

Ordering Number		Dealtage	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
1NM70L-T92-B	1NM70G-T92-B	TO-92	G	D	S	Tape Box	
1NM70L-T92-K	1NM70G-T92-K	TO-92	G	D	S	Bulk	

Note: Pin Assignment: G: Gate S: Source D: Drain



MARKING



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■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	700	٧
Gate-Source Voltage		V_{GSS}	±30	٧
Continuous Drain Current		I _D	1	Α
Pulsed Drain Current (Note 2)		I_{DM}	2	Α
Avalanche Energy (Note 3)	Single Pulsed	E _{AS}	22	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.8	V/ns
Power Dissipation (T _A =25°C)		P_{D}	1.6	W
Junction Temperature		T_J	+150	Ô
Storage Temperature		T _{STG}	-55 ~ +150	Ô

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=138mH, I_{AS} =0.5A, V_{DD} =50V, R_{G} =25 Ω , Starting T_{J} = 25°C
- 4. $I_{SD} \le 1.0 A$, di/dt $\le 200 A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25 ^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	180	°C/W	
Junction to Case	θ _{JC}	75	°C/W	

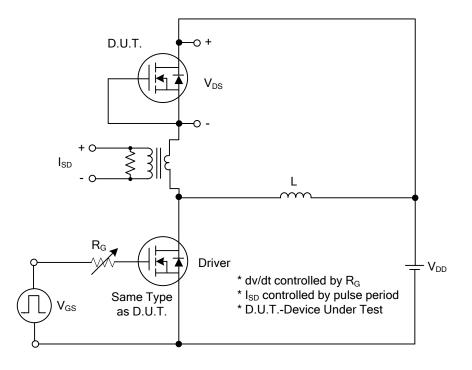
■ ELECTRICAL CHARACTERISTICS (T_C =25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	700			V
Drain-Source Leakage Current		I_{DSS}	$V_{DS} = 700V, V_{GS} = 0V$			10	μΑ
Gate-Source Leakage Current	Forward	I _{GSS}	$V_{GS} = 30V, V_{DS} = 0V$			100	nA
	Reverse		$V_{GS} = -30V, V_{DS} = 0V$			-100	nΑ
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5		4.5	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	$V_{GS} = 10V, I_D = 0.5A$			3.5	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance	Input Capacitance Output Capacitance				124.7		pF
Output Capacitance			V_{DS} =25V, V_{GS} =0V, f =1MHz		69.4		pF
Reverse Transfer Capacitance		C_{RSS}			6.2		pF
SWITCHING CHARACTERISTICS	S						
Total Gate Charge		Q_G	V 500V V 40V		9.8		nC
Gate-Source Charge		Q_GS	V _{DS} =560V, V _{GS} =10V, I _D =1A, I _G =1mA (Note 1, 2)		2.8		nC
Gate-Drain Charge		Q_GD	IB- IA, IG- IIIA (Note 1, 2)		1.5		nC
Turn-On Delay Time		t _{D (ON)}			3.6		ns
Turn-On Rise Time		t_R	$V_{DD} = 100V, V_{GS} = 10V, I_{D} = 1A,$		16.7		ns
Turn-Off Delay Time		$t_{D(OFF)}$	R _G =25Ω (Note 1, 2)		19		ns
Turn-Off Fall Time		t_{F}			38.3		ns
DRAIN-SOURCE DIODE CHARA	CTERISTIC	cs					
Maximum Continuous Drain-Source Diode		I _S				1	Α
Forward Current						ı	А
Maximum Pulsed Drain-Source Diode		I _{SD}				2	Α
Forward Current							٨
Drain-Source Diode Forward Voltage		V_{SD}	I _S =1.0A, V _{GS} =0V			1.4	V
Reverse Recovery Time		t _{rr}	I _F =1.0A, V _{DD} =100V 128				ns
Reverse Recovery Charge		Q_{rr}	di/dt = 100A/µs		0.6		μC

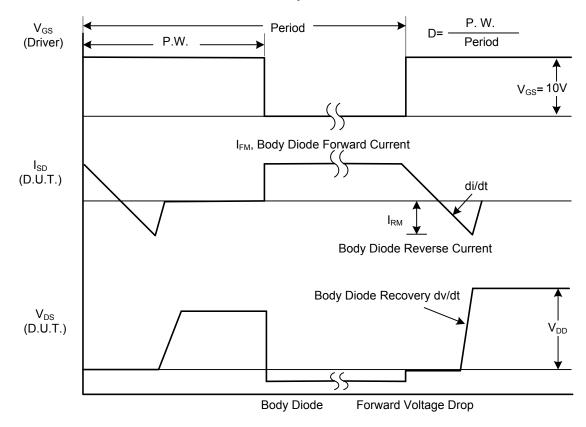
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle≤2%.

^{2.} Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

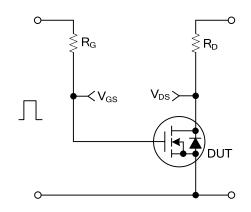


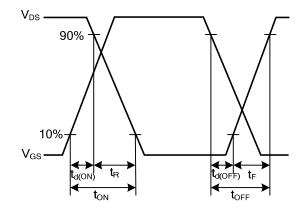
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

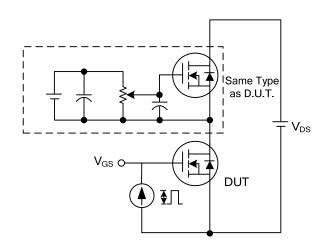
TEST CIRCUITS AND WAVEFORMS

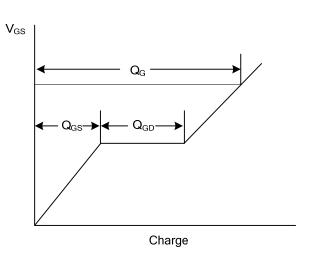




itching Test Circuit

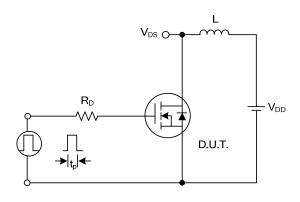
Switching Waveforms

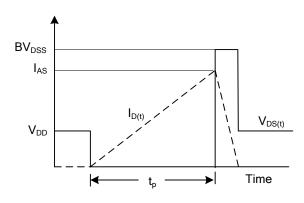




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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